

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10549430	KATHIRGAMANATHAN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Dawn Garrett	1794

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
428	690, 704, 917 (See EAST search history for all listed)	2/14/08	/DG/
313	504, 506	2/14/08	/DG/
257	E51.041, E51.047, E51.05, E51.051	2/14/08	/DG/
544	180, 229	2/14/08	/DG/
546	13	2/14/08	/DG/
548	110	2/14/08	/DG/

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST search (see search history printout) - Databases: JPO, EPO, Derwent, USPat, USPGPub	2/14/08	/DG/
Inventor Name Search	2/14/08	/DG/
STIC structure search by EIC1700 (see printout)	12/20/07	/DG/
Class/subclass search (limited by text) updated in EAST	6/10/08	/DG/
Reviewed prior STIC structure search	6/10/08	/DG/
Updated Inventor Name Search	6/10/08	/DG/
EAST search (see search history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	6/10/08	/DG/

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	Interference search done in EAST - text searching in claim field, USPGPUB database (see search history printout)	6/10/08	/DG/